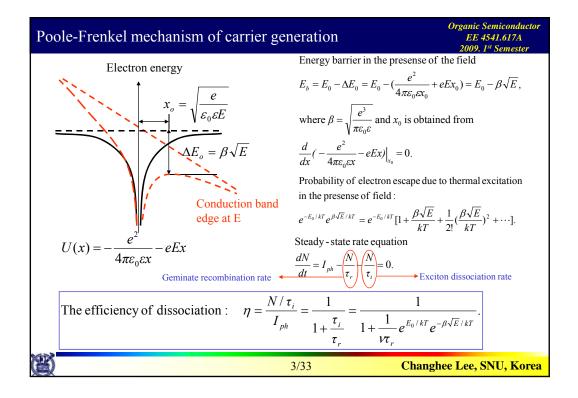
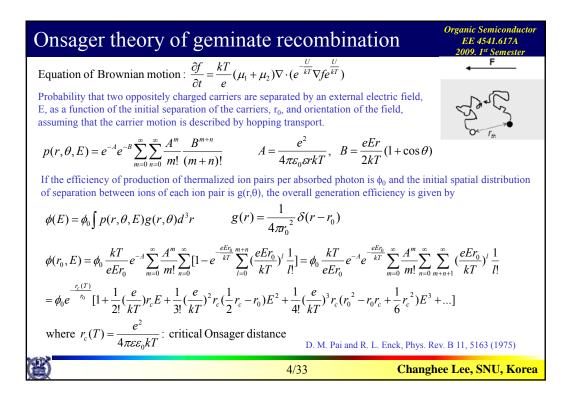
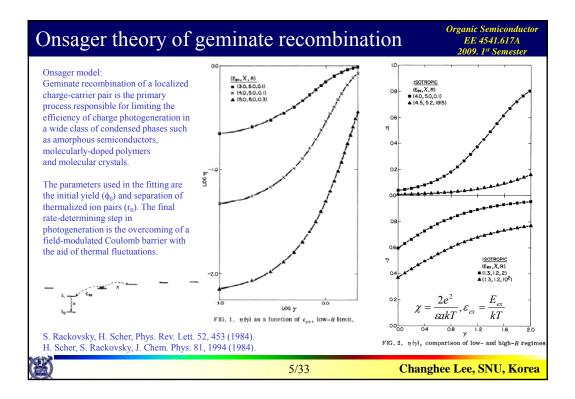
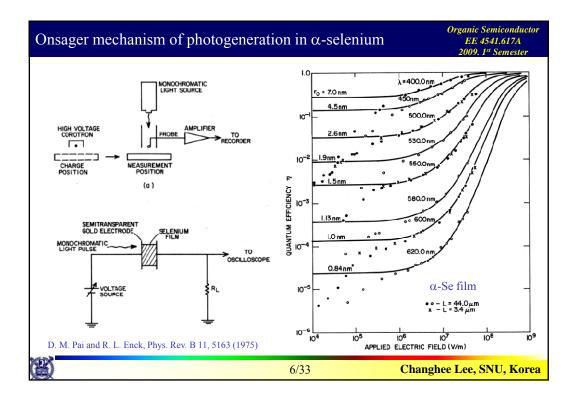


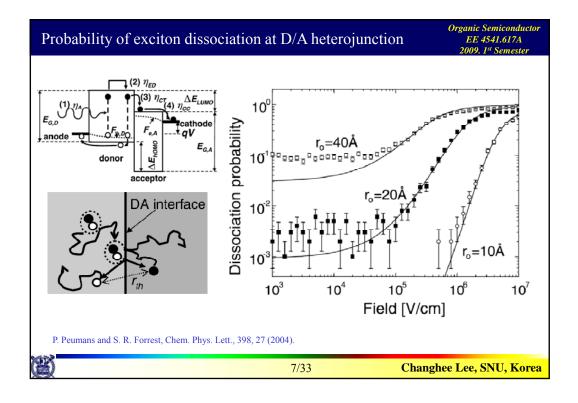
Exciton binding energy and mechanism of the carrier generation	Organic Semiconductor EE 4541.617A 2009. I st Semester
 Large exciton binding energy? Organic semiconductor: small band width, low dielectric constant (3~4 Photoexcitation → formation of excitons with strong Coulomb energy e.d. poly-diacetylene (PDA), Eg~0.5 eV. 	
 Mechanism of the carrier generation upon photoexcitation The applied electric field appears to enhance the carrier generation efficiency photoexcitation. Reduction of the thermal ionization energy for the separation of two chargemutual Coulomb attraction. 	ciency upon
(1) Poole-Frenkel mechanism	
(2) Onsager mechanism	
2/33 Chan	ghee Lee, SNU, Korea

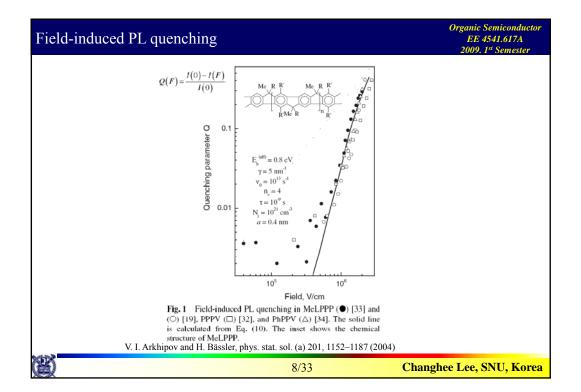


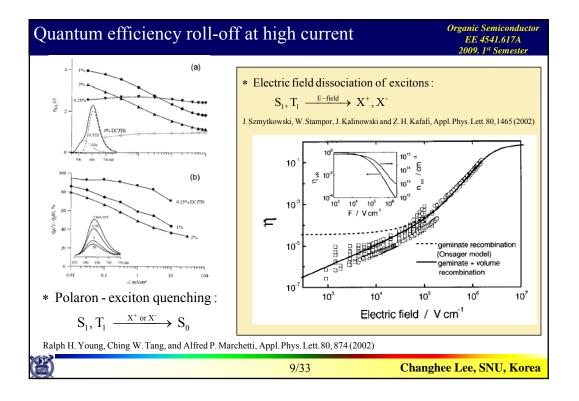


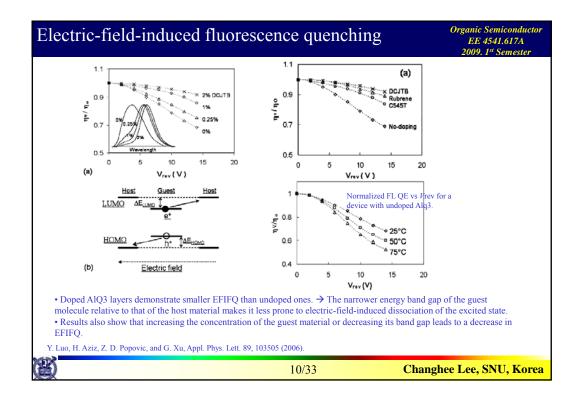


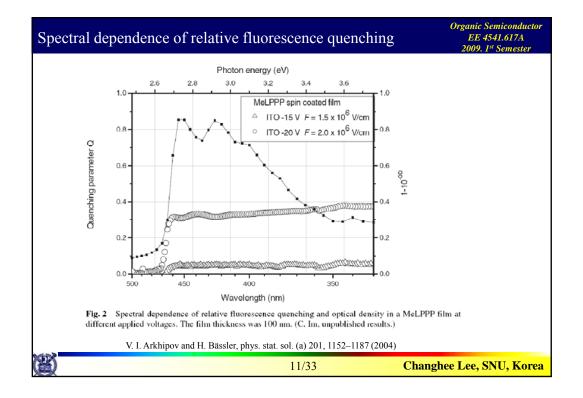


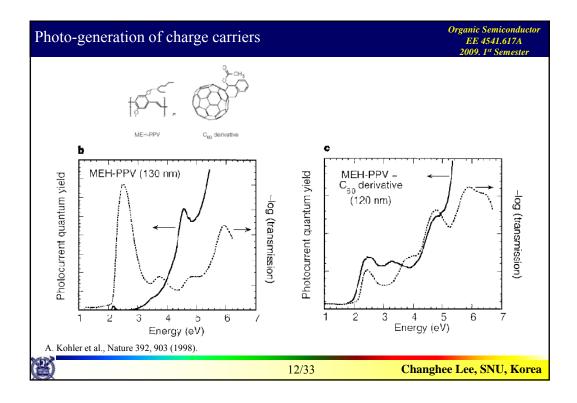


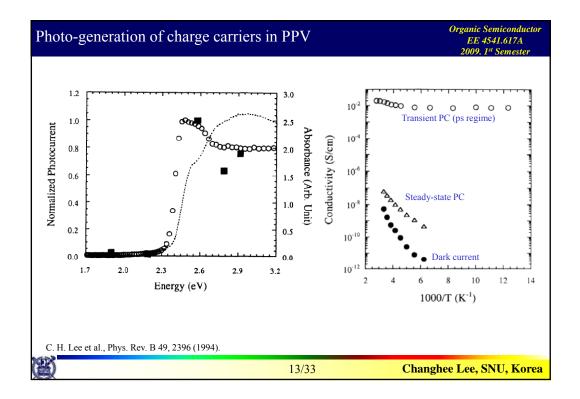


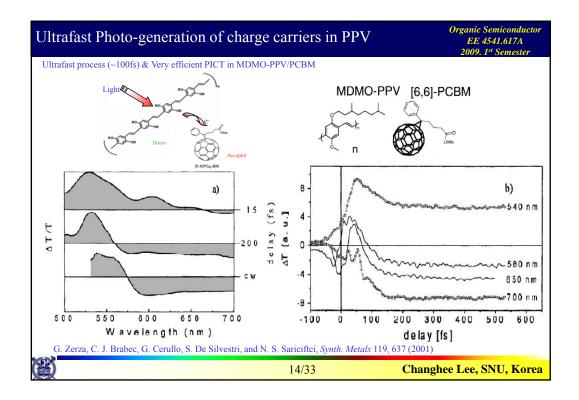


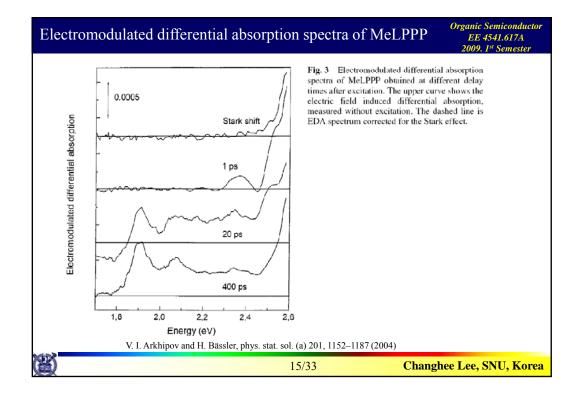


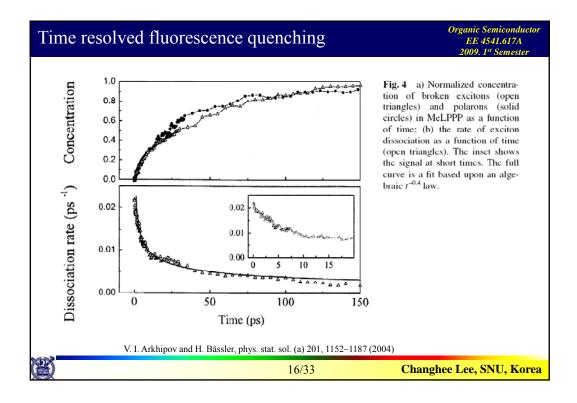


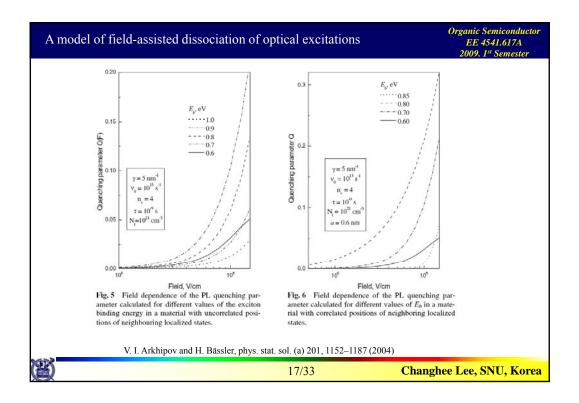


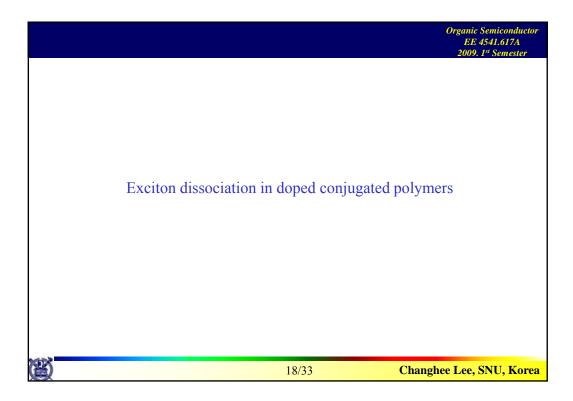


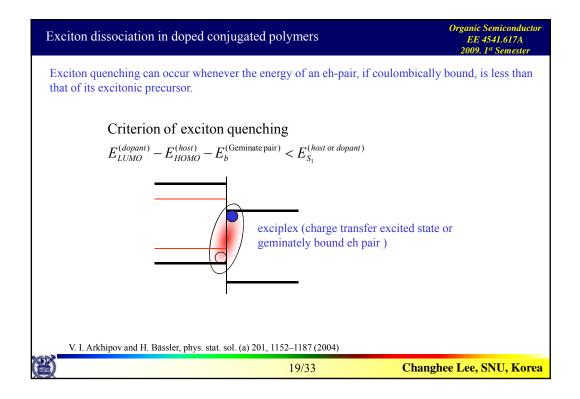


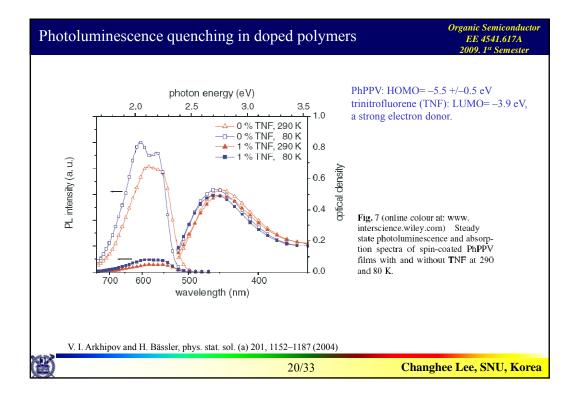


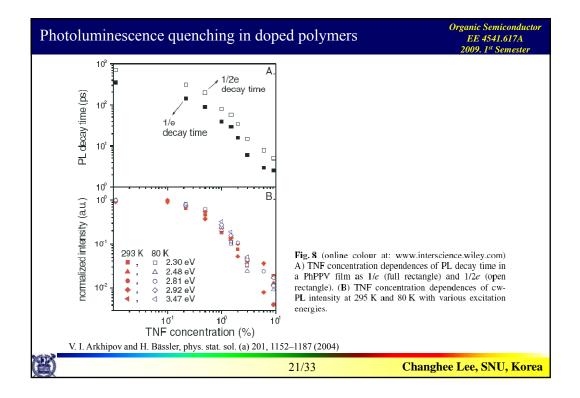


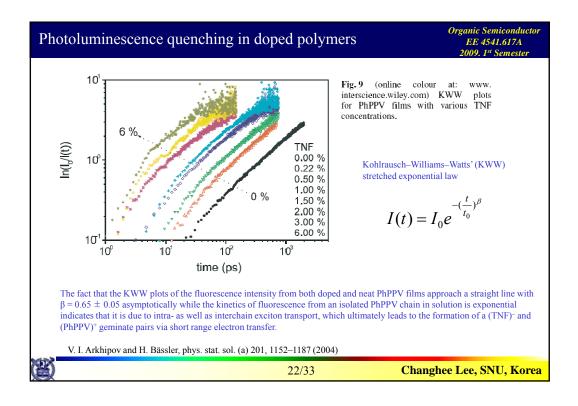


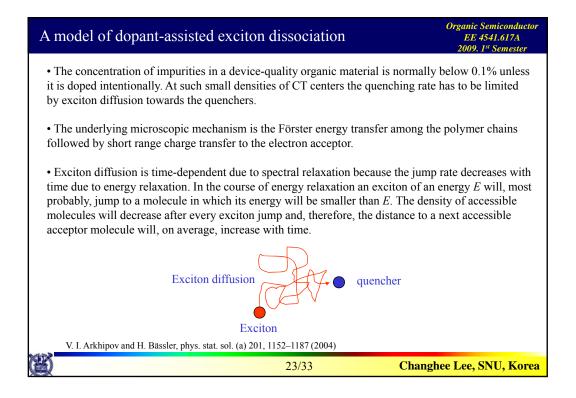




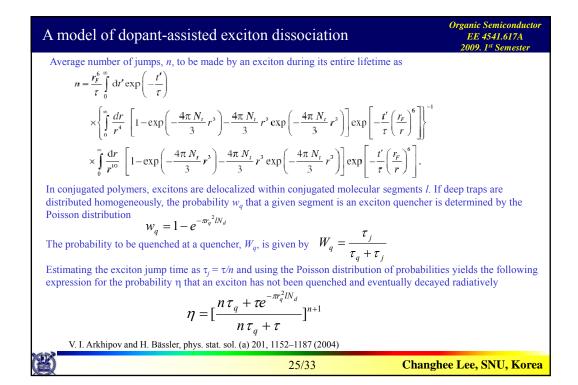


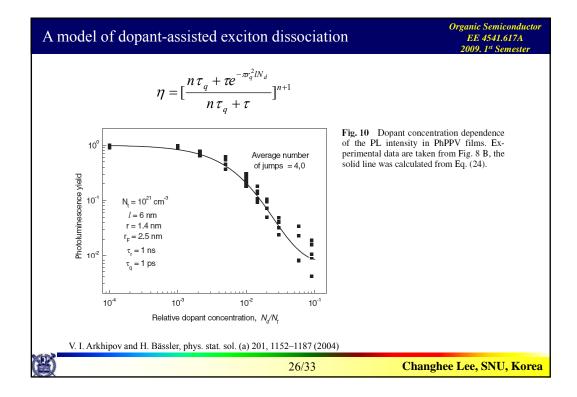


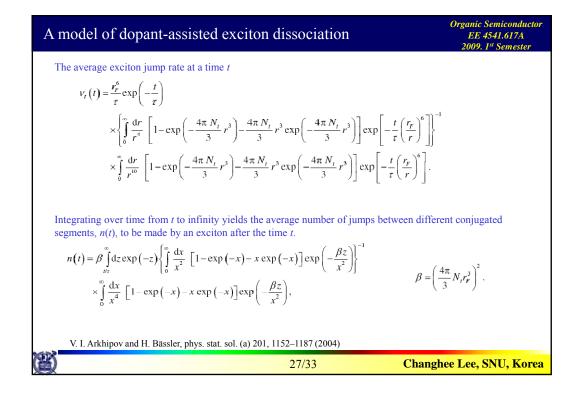


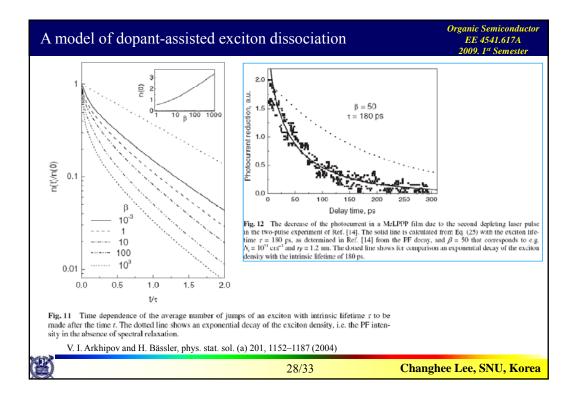


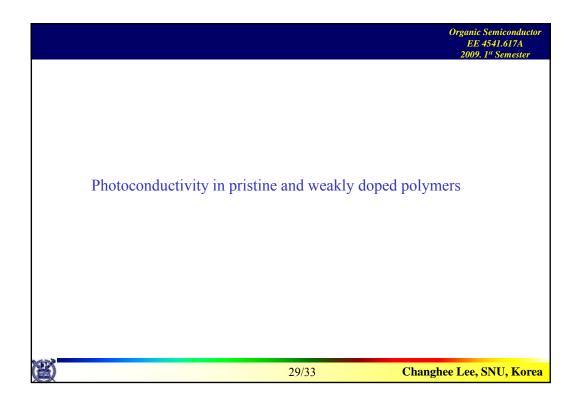
A model of dopant-assisted exciton dissociation	Organic Semiconductor EE 4541.617A 2009. 1 st Semester
Probability density of having an acceptor over the distance r is given by the Poisson distri $\frac{4\pi}{3}$	
$w(\mathbf{r}) = 4\pi r^2 N(E)e^{-\frac{4\pi}{3}r^3 N(E)}$	
where $N(E)$ is the density of acceptor molecules, accessible for an exciton of an energy E .	
If an exciton has the nearest accessible molecule over the distance r , the probability $p(r, t)$ yet jumped to this molecule until the time t is also described by the Poisson formula	that it has not
$p(r,t) = e^{-\nu(r)t} = e^{-\frac{t}{\tau}(\frac{r_F}{r})^6} \text{Forster energy transfer rate : } \nu(r) = \frac{1}{\tau}(\frac{r_F}{r})^6$	
$\therefore w(E,r,t) = 4\pi r^2 N(E) e^{-\frac{4\pi}{3}r^3 N(E) - \frac{t}{\tau} (\frac{r_F}{r})^6}$	
The energy distribution of such states is given by the product of $W(E, t, r)$ and the exciton $g(E)$ as	ic DOS distribution
$f(E,r,t) = A(t)r^{2}g(E)N(E)e^{-\frac{4\pi}{3}r^{3}N(E)-\frac{t}{\tau}(\frac{r_{F}}{r})^{6}}$	
where $A(t)$ is the normalization constant.	
$A(t) = e^{-\frac{t}{\tau}} \left[\int_0^\infty dr r^2 \int_0^\infty dEg(E) N(E) e^{-\frac{4\pi}{3}r^3 N(E) - \frac{t}{\tau} \left(\frac{r_E}{r}\right)^6} \right]^{-1}$	
V. I. Arkhipov and H. Bässler, phys. stat. sol. (a) 201, 1152–1187 (2004)	
24/33 Changh	ee Lee, SNU, Korea

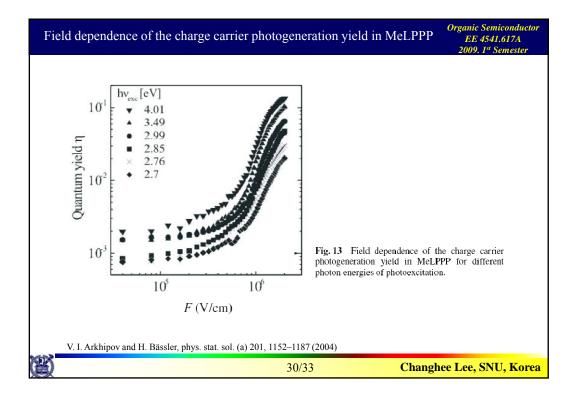


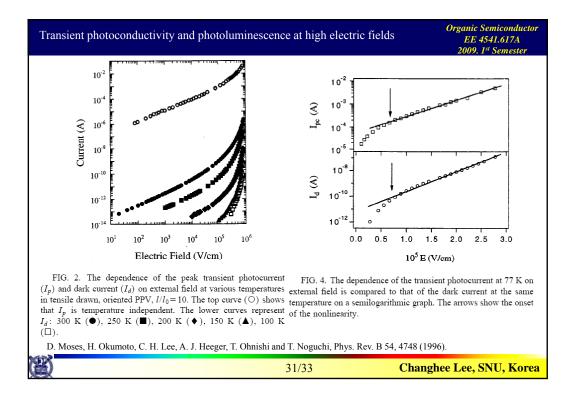


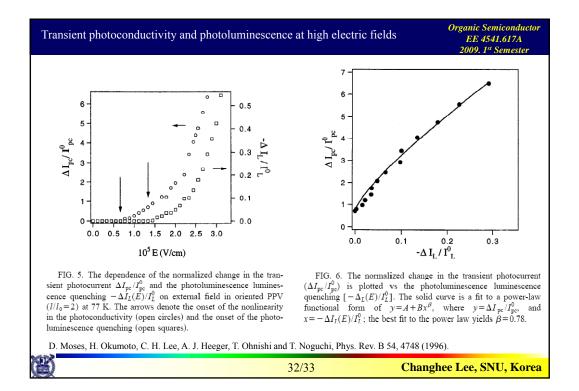












Organic Semiconductor Mechanism of carrier generation in polyphenylene vinylene EE 4541.617A 009. 1st Semeste • The fast transient photocurrent is independent of temperature (T); • The fast transient photocurrent is linearly proportional to the light intensity; • The fast transient photocurrent is linearly proportional to the external field (E) in the low-field regime, at fields orders of magnitude below the onset of nonlinear transport. \rightarrow a carrier generation mechanism independent of external field. At high fields, the transient and steady-state photoconductivity both increase exponentially with E. The better the polymer chain alignment, the lower the threshold field for the onset of nonlinear transport. The dependence of the nonlinearity on sample orientation and order, and the appearance of a similar exponential component in the dark current imply that the nonlinearity must arise from nonlinear carrier transport rather than nonlinear carrier generation; the nonlinear increase in transient photocurrent with field results from a field-induced increase in the transport mobility. • The absence of correlation between $\Delta \sigma(E)/\sigma_{\rm nc}(0)$ and $\Delta I_I(E)/I_L(0)$ implies that field-induced dissociation of strongly bound excitons is not the mechanism responsible for the luminescence quenching. • The relatively low field required for the onset of luminescence quenching implies a weak exciton binding energy. D. Moses, H. Okumoto, C. H. Lee, A. J. Heeger, T. Ohnishi and T. Noguchi, Phys. Rev. B 54, 4748 (1996). Changhee Lee, SNU, Korea 33/33